

## # 1st charge transport mechanism

$$\bar{v}_h = \mu_p \bar{E} \quad , \quad \bar{v}_e = \mu_n \bar{E}$$

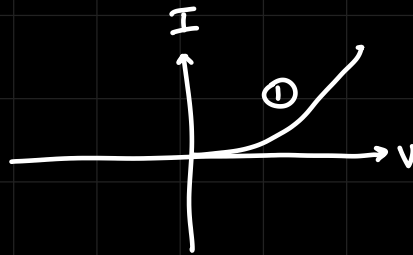
\*  $\left\{ \begin{array}{l} \text{primary transport : drift} \\ \text{secondary transport : diffusion} \end{array} \right.$

→ tunnelling is also a transport mechanism

in case of highly doped junctions

→ thermionic

PN:



$$\textcircled{1} \quad I = I_s e^{\frac{eV}{k_B T n}} \quad \rightarrow \text{non ideality factor}$$

## # DRIFT TRANSPORT MECHANISM

Spintronics: spin motion related to electrons

movement of charges because of  
an electric field  $\equiv$  DRIFT

drift  
velocity:

$$\bar{v}_h = \mu_p \bar{E}$$

$$\bar{v}_e = -\mu_n \bar{E}$$

mobility

# # DRUDE model

When  $e^-$  move, we can visualize interaction as that of a gas i.e. very less

$\tau$  { relaxation time approximation: time b/w 2 successive  $e^-$  collisions  
OR mean free time  
OR collision time

→ (25-30 nm for Si/Ge)

mean free path = some thing but the distance between 2 successive collisions

$\tau$  is independent of  $e^-$  position and velocity

ballistic missile: travels without deviation

ballistic motion:  $e^-$  travelling through the mean free path without deviation

but if  $e^-$  goes beyond mean free path, there are collisions and hence resistance.

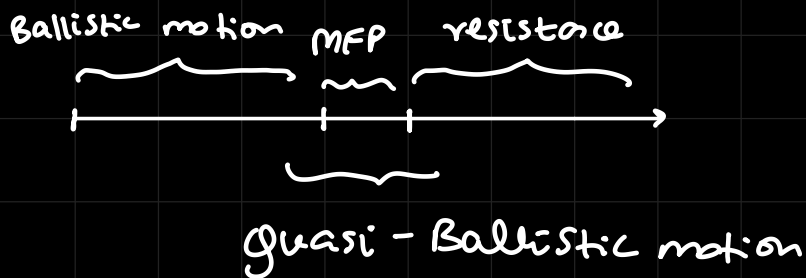
probability that an  $e^-$  faces

collision per time  $\rightarrow \frac{1}{\tau}$

within small time,  
 $\frac{dt}{\tau}$

# Quasi-Ballistic Motion

↳ near the mean free path,  
midway between collisions and  
no-collisions



$$m_e \frac{d\bar{v}}{dt} = -e\bar{E}$$

integration (

$$\bar{v}(t) = \frac{-e\bar{E}t}{m_e}$$

drift  
velocity

mean free time

$$\bar{v} = \frac{-e\bar{E}\tau}{m_e} \quad \text{--- ①}$$



(e-) charges passing in  
unit time:  $n\bar{v}A$

$$\text{current} : -en\bar{v}A$$

$$\text{current density} : \bar{J} = n\bar{v}(-e)$$

$$\text{from ①} \rightarrow \bar{J} = \underbrace{\frac{ne^2\tau}{m_e}}_{\sigma} \bar{E}$$

$$\bar{J} = \sigma \bar{E}$$

conductivity

$$J = \sigma E = \frac{E}{\rho}$$

$$\sigma = \frac{n e^2 \tau}{m_e} = n \mu e \quad \begin{array}{l} \nearrow \# \text{ of } e^- \\ \text{charge} \\ \downarrow \\ \text{mobility} \end{array}$$

resistivity,  $\rho = \frac{m_e}{n e^2 \tau}$

mobility = avg of relaxation time  $\tau$

$$\mu = \frac{e \tau}{m_e^*}$$

$$|\vec{v}| = \mu |\vec{E}|$$

$$\rightarrow \sigma = n \mu e \quad \begin{array}{l} \nearrow \text{unit: } \text{cm}^2/\text{V s} \quad \uparrow \text{second} \\ \quad \quad \quad \downarrow \text{volt} \end{array}$$

$$\downarrow \frac{e \tau}{m^*}$$

{ we can find  $n$  from  $m^*$  }

{ carrier density  $\propto \frac{1}{\text{mobility}}$  } we need to balance

$m^* \downarrow \rightarrow \mu \uparrow$  but  $m^* \propto \text{curvature}$   
and so DOS goes down

Si balances  $\mu$  and carrier density, <sup>well</sup> and hence  $I \uparrow$   
 $\hookrightarrow$  hence preferred

$$\left. \begin{array}{l} m_e = 0.98m_0 \\ m_h = 0.19m_0 \end{array} \right\} \text{GaAs} \quad \text{and} \quad \text{Si} \left\{ m_* = 0.15m_0 \right.$$

not much difference  
BUT

$$\left. \begin{array}{l} \mu_{\text{GaAs}} = 5000 \text{ cm}^2/\text{Vs} \\ \mu_{\text{Si}} = 1200 \text{ cm}^2/\text{Vs} \end{array} \right\} \checkmark$$

So,  $\tau$  plays a major role

$$J_n = \mu_n \bar{E} \cdot n \cdot q$$

$$J_{\text{total}} = q(\mu_n n + \mu_p p) \bar{E}$$

note:  $\mu_{n_{\text{Si}}} = 1200 \text{ cm}^2/\text{Vs} \quad (e^-)$

$$\mu_{p_{\text{Si}}} = 600 \text{ cm}^2/\text{Vs} \quad (\text{hole})$$

because of difference in effective mass  
( $m_e \gg m_h$ )

NMOS: MOSFET with n channel ( $e^-$ )

PMOS: p channel (holes)

We take size of PMOS as double of NMOS

because of  $\mu_p$  and  $\mu_n$  ( $\mu_p \approx \frac{1}{2} \mu_n$ )

to balance current from PMOS & NMOS

$$(m_* \rightarrow \mu \rightarrow \sigma \rightarrow J \rightarrow I)$$

# # SCATTERING MECHANISM IN A SC DEVICE

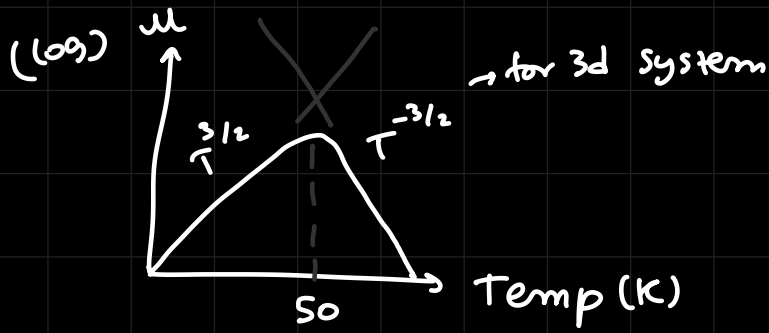
→ Matthiessen's Rule: Resistivity is the sum of all individual resistivity in the system

$$\frac{1}{\tau} = \frac{1}{\tau_{\text{phonon}}} + \frac{1}{\tau_{\text{impurity}}}$$
$$\frac{1}{\mu} = \frac{1}{\mu_{\text{phonon}}} + \frac{1}{\mu_{\text{impurity}}}$$

↓  
conductivity  $\sigma = \frac{1}{\rho}$

## Scattering mechanisms

- ↳ Defect
  - ↳ Crystal
  - ↳ Impurity
    - ↳ Neutral
    - ↳ Ionized
  - ↳ Alloy
- ↳ carrier-carrier
- ↳ Lattice
  - ↳ Intravalley
    - ↳ Acoustic
      - ↳ Deformation Potential
      - ↳ Piezo electric
    - ↳ Optical
      - ↳ Non Polar
      - ↳ Polar
  - ↳ Intervalley
    - ↳ Acoustic/optical



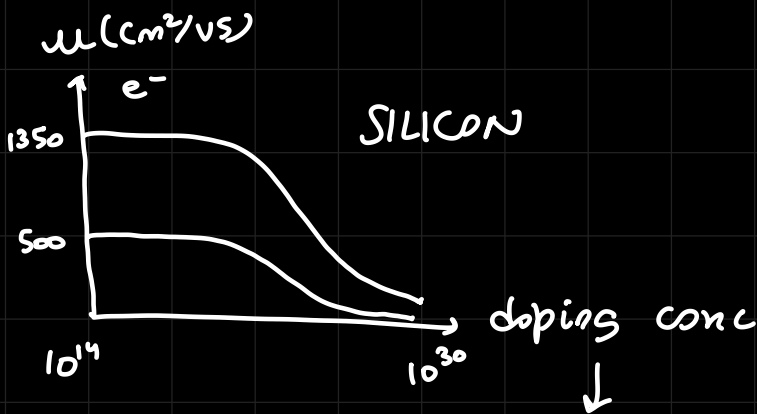
related to doping

impurity scattering dominates at low temps

lattice scattering dominates at high temps

remember phonon generation

temp ↑, vibrations ↑, scattering ↑,  $\mu$  ↓



below 5K, lattice vibrations are very small

↓

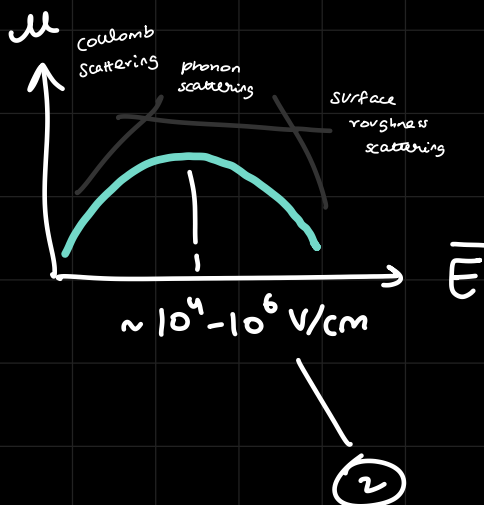
carrier density ↑

but  $\mu$  ↓

tradeoff ↓

because  $\tau$  ↓ ↓

(more carriers in limited space)

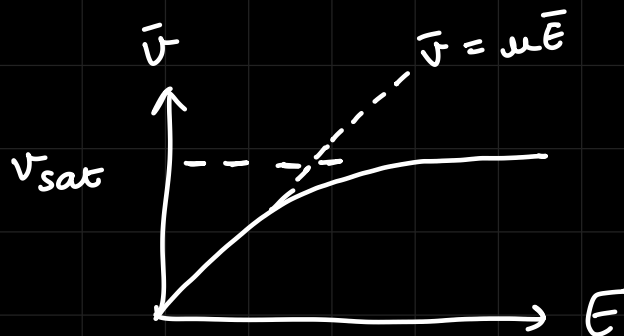


$$v_t = \mu \bar{E}$$

but practically,  $v$  does not increase linearly with  $\bar{E}$

since  $\mu$  does not linearly increase as  $\bar{E} \uparrow$  in (2)

$$v = \frac{\mu_0}{1 + \frac{\mu_0 E}{v_{sat}}} E$$



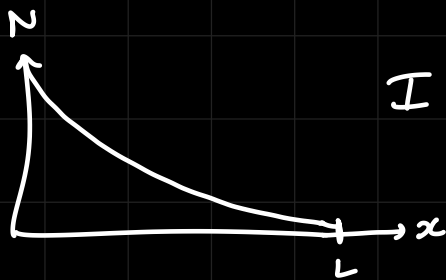
Velocity  
saturation



## # Second Transport Mechanism : Diffusion

$$J_n = qD_n \frac{dn}{dx}, \quad J_p = -qD_p \frac{dp}{dx}$$

if current density is non linear, current will also be non-linear



I will also be exponential

forward bias: diffusion (major)

Reverse bias: drift (major)

$$\frac{D}{\mu} = \frac{kT}{q}$$

Einstein's  
Relation